Functional Safety
Switch Amplifier HiC283\*

**Manual** 







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## 1 Introduction

## 1.1 Content of this Document

This document contains information for usage of the device in functional safety-related applications. You need this information to use your product throughout the applicable stages of the product life cycle. These can include the following:

- Product identification
- Delivery, transport, and storage
- Mounting and installation
- Commissioning and operation
- Maintenance and repair
- Troubleshooting
- Dismounting
- Disposal



#### Note

This document does not substitute the instruction manual.



#### Note

For full information on the product, refer to the instruction manual and further documentation on the Internet at www.pepperl-fuchs.com.

The documentation consists of the following parts:

- Present document
- Instruction manual
- Manual
- Datasheet

Additionally, the following parts may belong to the documentation, if applicable:

- · EU-type examination certificate
- EU declaration of conformity
- Attestation of conformity
- Certificates
- Control drawings
- FMEDA report
- Assessment report
- Additional documents

For more information about Pepperl+Fuchs products with functional safety, see www.pepperl-fuchs.com/sil.

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## 1.2 Safety Information

## **Target Group, Personnel**

Responsibility for planning, assembly, commissioning, operation, maintenance, and dismounting lies with the plant operator.

Only appropriately trained and qualified personnel may carry out mounting, installation, commissioning, operation, maintenance, and dismounting of the product. The personnel must have read and understood the instruction manual and the further documentation.

#### **Intended Use**

The device is only approved for appropriate and intended use. Ignoring these instructions will void any warranty and absolve the manufacturer from any liability.

The device is developed, manufactured and tested according to the relevant safety standards.

Use the device only

- · for the application described
- with specified environmental conditions
- · with devices that are suitable for this safety application

## **Improper Use**

Protection of the personnel and the plant is not ensured if the device is not used according to its intended use.



## 1.3 Symbols Used

This document contains symbols for the identification of warning messages and of informative messages.

## **Warning Messages**

You will find warning messages, whenever dangers may arise from your actions. It is mandatory that you observe these warning messages for your personal safety and in order to avoid property damage.

Depending on the risk level, the warning messages are displayed in descending order as follows:



## Danger!

This symbol indicates an imminent danger.

Non-observance will result in personal injury or death.



## Warning!

This symbol indicates a possible fault or danger.

Non-observance may cause personal injury or serious property damage.



#### Caution!

This symbol indicates a possible fault.

Non-observance could interrupt the device and any connected systems and plants, or result in their complete failure.

## **Informative Symbols**



## Note

This symbol brings important information to your attention.



#### **Action**

This symbol indicates a paragraph with instructions. You are prompted to perform an action or a sequence of actions.

## 2 Product Description

## 2.1 Function

#### General

This isolated barrier is used for intrinsic safety applications.

The device transfers digital signals from NAMUR sensors or dry contacts from the hazardous area to the non-hazardous area.

Via switches the mode of operation can be reversed and the line fault detection can be switched off.

This device mounts on a HiC termination board.

## **HiC2831 and HiC2832**

The input controls two passive transistor outputs with a resistive output characteristic (acc. to EN60947-5-6).

The outputs have three defined states: low impedance state: 1-signal = 1.8 k $\Omega$ , high impedance state: 0-signal = 14 k $\Omega$  and fault > 100 k $\Omega$ .

This output characteristic offers line fault transparency on the signal lines.

## HiC2831R1 and HiC2832R1

The input controls two passive transistor outputs with a resistive output characteristic.

The outputs have three defined states: 1-signal = 6.5 V voltage drop, high impedance state: 0-signal = 33 k $\Omega$  and 6.5 V voltage drop and fault > 100 k $\Omega$ .

This output characteristic offers line fault transparency on the signal lines.

#### HiC2831R2 and HiC2832R2

The input controls two passive transistor outputs with a resistive output characteristic.

The outputs have three defined states: low impedance state: 1-signal = 5 k $\Omega$ , high impedance state: 0-signal = 15 k $\Omega$  and fault > 100 k $\Omega$ .

This output characteristic offers line fault transparency on the signal lines.

#### HiC2831R3 and HiC2832R3

The input controls two passive transistor outputs with a resistive output characteristic.

The outputs have three defined states: low impedance state: 1-signal = 100  $\Omega$  to 600  $\Omega$ , high impedance state: 0-signal = 19 k $\Omega$  and fault > 100 k $\Omega$ .

This output characteristic offers line fault transparency on the signal lines.

## HiC2831R4 and HiC2832R4

The input controls two passive transistor outputs with a resistive output characteristic.

The outputs have three defined states: low impedance state: 1-signal = 472  $\Omega$ , high impedance state: 0-signal = 1.4 k $\Omega$  and fault > 100 k $\Omega$ .

This output characteristic offers line fault transparency on the signal lines.

#### HiC2831R5 and HiC2832R5

The input controls two passive transistor outputs with a resistive output characteristic.

The outputs have three defined states: low impedance state: 1-signal = 8.8 k $\Omega$ , high impedance state: 0-signal = 45.5 k $\Omega$  and fault > 100 k $\Omega$ .

This output characteristic offers line fault transparency on the signal lines.



## 2.2 Interfaces

The device has the following interfaces:

- Safety relevant interfaces:
  - 1-channel devices: input I, output I, output II (optional)
  - 2-channel devices: input I, input II, output I, output II
- · Non-safety relevant interfaces: power supply, fault output



#### Note

For corresponding connections see datasheet.

## 2.3 Marking

Pepperl+Fuchs Group Lilienthalstraße 200, 68307 Mannheim, Germany Internet: www.pepperl-fuchs.com

HiC2831, HiC2832, HiC2831R1, HiC2832R1 HiC2831R2, HiC2832R2, HiC2831R3, HiC2832R3	Up to SIL 2
HiC2831R4, HiC2832R4, HiC2831R5, HiC2832R5	



#### Note

If you design the safety loops in homogeneous redundancy (HFT = 1), you can use the devices in applications up to SIL 3.

## 2.4 Standards and Directives for Functional Safety

## **Device-specific standards and directives**

Functional safety	IEC/EN 61508, part 2, edition 2010:
	Functional safety of electrical/electronic/programmable electronic
	safety-related systems (manufacturer)

## System-specific standards and directives

Functional safety  IEC 61511-1:2016+COR1:2016+A1:2017  EN 61511-1:2017+A1:2017  Functional safety – Safety instrumented systems for the procindustry sector (user)	ess
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Planning

# 3 Planning

## 3.1 System Structure

## 3.1.1 Low Demand Mode of Operation

If there are two control loops, one for the standard operation and another one for the functional safety, then usually the demand rate for the safety loop is assumed to be less than once per year.

The relevant safety parameters to be verified are:

- the PFD<sub>avg</sub> value (average Probability of dangerous Failure on Demand) and the T<sub>1</sub> value (proof test interval that has a direct impact on the PFD<sub>avg</sub> value)
- the SFF value (Safe Failure Fraction)
- the HFT architecture (Hardware Fault Tolerance)

## 3.1.2 High Demand or Continuous Mode of Operation

If there is only one safety loop, which combines the standard operation and safety-related operation, then usually the demand rate for this safety loop is assumed to be higher than once per year.

The relevant safety parameters to be verified are:

- the PFH value (Probability of dangerous Failure per Hour)
- Fault reaction time of the safety system
- the SFF value (Safe Failure Fraction)
- the HFT architecture (Hardware Fault Tolerance)

#### 3.1.3 Safe Failure Fraction

The safe failure fraction describes the ratio of all safe failures and dangerous detected failures to the total failure rate.

$$SFF = (\lambda_s + \lambda_{dd}) / (\lambda_s + \lambda_{dd} + \lambda_{du})$$

A safe failure fraction as defined in IEC/EN 61508 is only relevant for elements or (sub)systems in a complete safety loop. The device under consideration is always part of a safety loop but is not regarded as a complete element or subsystem.

For calculating the SIL of a safety loop it is necessary to evaluate the safe failure fraction of the elements and subsystems, but not of a single device.

Nevertheless the SFF of the device is given in this document for reference.

## 3.2 Assumptions

The following assumptions have been made during the FMEDA:

- Failure rate based on the Siemens standard SN 29500.
- Failure rates are constant, wear is not considered.
- External power supply failure rates are not included.
- The safety-related device is considered to be of type A device with a hardware fault tolerance of 0.
- The device will be used under average industrial ambient conditions comparable to the classification "stationary mounted" according to MIL-HDBK-217F.
  - Alternatively, operating stress conditions typical of an industrial field environment similar to IEC/EN 60654-1 Class C with an average temperature over a long period of time of 40 °C may be assumed. For a higher average temperature of 60 °C, the failure rates must be multiplied by a factor of 2.5 based on experience. A similar factor must be used if frequent temperature fluctuations are expected.
- Do not use more than one input channel of a multi-channel device for a safety loop, as the channels of the device use common components. Observe that a multi-channel device contains components that affect the behavior of all channels.

## **SIL 2 Application**

- To build a SIL safety loop for the defined SIL, it is assumed as an example that this device uses 10 % of the available budget for PFD<sub>avg</sub>/PFH.
- For a SIL 2 application operating in low demand mode the total PFD<sub>avg</sub> value of the SIF (Safety Instrumented Function) should be smaller than 10<sup>-2</sup>, hence the maximum allowable PFD<sub>avg</sub> value would then be 10<sup>-3</sup>.
- For a SIL 2 application operating in high demand mode the total PFH value of the SIF should be smaller than 10<sup>-6</sup> per hour, hence the maximum allowable PFH value would then be 10<sup>-7</sup> per hour.
- Since the safety loop has a hardware fault tolerance of 0 and it is a type A device, the SFF must be > 60 % according to table 2 of IEC/EN 61508-2 for a SIL 2 (sub) system.

# 3.3 Safety Function and Safe State

## **Safe State**

The safe state of output I and output II is the high impedance state or the fault state.

## **Safety Function**

HiC2831\*

Switch	Position	Function			
Output I and	Output I and output II				
S1	II	Normal mode of operation	If a low current is present at input I, output I and output II are high impedant (safe state).		
S1	I	Inverse mode of operation	If a high current is present at input I, output I and output II are high impedant (safe state).		

Table 3.1 Switch settings HiC2831\*

## HiC2832\*

Switch	Position	Function					
Channel I	Channel I						
S1	II	Normal mode of operation	If a low current is present at input I, output I is high impedant (safe state).				
S1	I	Inverse mode of operation If a high current is present at input I, output I is high impedant (safe state).					
Channel II	Channel II						
S3	II	Normal mode of operation	If a low current is present at input II, output II is high impedant (safe state).				
S3	Ι	Inverse mode of operation	If a high current is present at input II, output II is high impedant (safe state).				

Table 3.2 Switch settings HiC2832\*

## **Line Fault Diagnostics**

If the line fault detection is enabled (mandatory, see datasheet), the input circuit is monitored in all device versions. If a line fault is detected, the outputs change in the fault state (safe state).



#### Note

The fault indication output is not safety relevant.

## **Reaction Time**

- The response time for the safety function between input and output is < 0.1 ms. Load conditions:
  - HiC283\*: 8 V, 1 kΩ
     HiC283\*R1: 24 V, 2 kΩ
     HiC283\*R2: 24 V, 250 Ω
     HiC283\*R3: 24 V, 4.2 kΩ
  - HiC283\*R4: 10 mA current source
     HiC283\*R5: 24V, 200 Ω to 250 Ω
- The fault detect and fault reaction time is < 100 ms. A fault diagnostics at the input leads to fault state



## Note

See corresponding datasheets for further information.



# 3.4 Characteristic Safety Values

Parameters	Characteristic values	Characteristic values		
Assessment type and documentation	Full assessment	Full assessment		
Device type	A			
Mode of operation	Low demand mode, high demar	nd mode or continuous mode		
HFT	0			
SIL	2			
SC	3			
MTBF <sup>1</sup> (HiC2831*)	154 years			
MTBF <sup>1</sup> (HiC2832*)	120 years	120 years		
PTC	99 %			
Safety function	Inverse mode of operation <sup>2</sup>	Normal mode of operation <sup>2</sup>		
λ <sub>safe</sub>	106 FIT	106 FIT		
$\lambda_{dd}$	3.3 FIT	3.3 FIT		
$\lambda_{du}$	26.8 FIT	22.8 FIT		
λtotal (safety function)	136 FIT	132 FIT		
SFF <sup>3</sup>	80 %	82 %		
PFH	2.68 x 10 <sup>-8</sup> 1/h	2.28 x 10 <sup>-8</sup> 1/h		
PFD <sub>avg</sub> for T <sub>1</sub> = 1 year	1.28 x 10 <sup>-4</sup>	1.09 x 10 <sup>-4</sup>		
PFD <sub>avg</sub> for T <sub>1</sub> = 2 years	2.56 x 10 <sup>-4</sup>	2.18 x 10 <sup>-4</sup>		
PFD <sub>avg</sub> for T <sub>1</sub> = 5 years	6.40 x 10 <sup>-4</sup>	5.44 x 10 <sup>-4</sup>		
Fault reaction time <sup>4</sup>	< 100 ms	< 100 ms		

Table 3.3

The characteristic safety values like PFD, PFH, SFF, HFT and  $T_1$  are taken from the FMEDA report. Observe that PFD and  $T_1$  are related to each other.

The function of the devices has to be checked within the proof test interval  $(T_1)$ .

acc. to SN29500. This value includes failures which are not part of the safety function/MTTR = 24 h.

<sup>&</sup>lt;sup>2</sup> The device can be used in two modes of operation, inverse of mode operation and normal mode of operation.

<sup>3 &</sup>quot;Annunciation failures" and "No effect failures" are not influencing the safety function and are therefor not included in the calculation of the SFF.

<sup>&</sup>lt;sup>4</sup> The combined fault detection and fault reaction time is the time in which the device reacts to an occurred fault.

## 3.5 Useful Lifetime

Although a constant failure rate is assumed by the probabilistic estimation this only applies provided that the useful lifetime of components is not exceeded. Beyond this useful lifetime, the result of the probabilistic estimation is meaningless as the probability of failure significantly increases with time. The useful lifetime is highly dependent on the component itself and its operating conditions – temperature in particular. For example, electrolytic capacitors can be very sensitive to the operating temperature.

This assumption of a constant failure rate is based on the bathtub curve, which shows the typical behavior for electronic components.

Therefore it is obvious that failure calculation is only valid for components that have this constant domain and that the validity of the calculation is limited to the useful lifetime of each component.

It is assumed that early failures are detected to a huge percentage during the installation and therefore the assumption of a constant failure rate during the useful lifetime is valid.

However, according to IEC/EN 61508-2, a useful lifetime, based on general experience, should be assumed. Experience has shown that the useful lifetime often lies within a range period of about 8 to 12 years.

As noted in DIN EN 61508-2:2011 note N3, appropriate measures taken by the manufacturer and plant operator can extend the useful lifetime.

Please note that the useful lifetime refers to the (constant) failure rate of the device. The effective life time can be higher.

The estimated useful lifetime is greater than the warranty period prescribed by law or the manufacturer's guarantee period. However, this does not result in an extension of the warranty or guarantee services. Failure to reach the estimated useful lifetime is not a material defect.

# 4 Mounting and Installation



## **Mounting and Installing the Device**

- 1. Observe the safety instructions in the instruction manual.
- 2. Observe the information in the manual.
- 3. Observe the requirements for the safety loop.
- 4. Connect the device only to devices that are suitable for this safety application.
- 5. Check the safety function to ensure the expected output behavior.

## 4.1 Configuration



## **Configuring the Device**

The device is configured via DIP switches. The DIP switches for setting the safety functions are on the side of the device.

- 1. De-energize the device before configuring the device.
- Remove the device.
- 3. Configure the device for the required safety function via the DIP switches, see chapter 3.3.
- 4. Secure the DIP switches to prevent unintentional adjustments.
- 5. Mount the device.
- 6. Connect the device again.



## Note

See corresponding datasheets for further information.

## 5

## **Operation**



## Danger!

Danger to life from missing safety function

If the safety loop is put out of service, the safety function is no longer guaranteed.

- Do not deactivate the device.
- Do not bypass the safety function.
- Do not repair, modify, or manipulate the device.



## Operating the device

- 1. Observe the safety instruction in the instruction manual.
- Observe the information in the manual.
- 3. Use the device only with devices that are suitable for this safety application.
- Correct any occurring safe failures within 24 hours. Take measures to maintain the safety function while the device is being repaired.

## 5.1 Proof Test Procedure

This section describes a possible proof test procedure. The user is not obliged to use this proposal. The user may consider different concepts with an individual determination of the respective effectiveness, e. g. concepts according to NA106:2018.

According to IEC/EN 61508-2 a recurring proof test shall be undertaken to reveal potential dangerous failures that are not detected otherwise.

Check the function of the subsystem at periodic intervals depending on the applied  $PFD_{avg}$  in accordance with the characteristic safety values. See chapter 3.4.

It is under the responsibility of the plant operator to define the type of proof test and the interval time period.

Check the settings after the configuration by suitable tests.

Equipment required:

- Digital multimeter with an accuracy of 0.1 %
  - Use for the proof test of the intrinsic safety side of the device a special digital multimeter for intrinsically safe circuits.
  - If intrinsically safe circuits are operated with non-intrinsically safe circuits, they must no longer be used as intrinsically safe circuits.
- For R4 version: current source 10.0 mA ±1 %
- For all other versions: dual power supply, set to 24 V DC resp. 8 V DC (NAMUR voltage).



## **Proof Test Procedure**

- Prepare a test set-up, see figures below.
- 2. Test the devices in the mode of operation they are used in. If necessary, change the configuration of the device. Verify the input and output values as given in table below.
- 3. Test each input channel individually.
- **4.** Simulate the sensor state by a potentiometer of 4.7 kΩ. The threshold must be between 1.4 mA and 1.9 mA. The hysteresis must be between 150 μA and 250 μA.
  - → For normal mode of operation the outputs must have a low impedance, if the input current is above the threshold. This state is indicated by yellow LED.
  - → For inverse mode of operation the outputs must have a low impedance, if the input current is below the threshold. This state is indicated by yellow LED.
- 5. Simulate the sensor state by a resistor  $R_{SC}$  (220  $\Omega$ , short circuit detection) or a resistor  $R_{LB}$  (150  $k\Omega$ , lead breakage detection).
  - → The device must detect an external fault. This state is indicated by red LED and the output of the corresponding channel must be in fault state.
- 6. Test the outputs with a certain current. Test that the outputs are definitely high impedant (see table, I<sub>off</sub>), if the yellow LED is off.
- 7. Set back the device to the original settings after the test.
- 8. Secure the DIP switches to prevent unintentional adjustments.

Device	R	U	I <sub>on</sub> (mA)	I <sub>off</sub> (mA)	I <sub>fault</sub> (mA)
HiC283*	1 kΩ	8 V	$2.6 \text{ mA} < I_{on} < 3.2 \text{ mA}$	$0.5 \text{ mA} < I_{\text{off}} < 0.6 \text{ mA}$	I <sub>fault</sub> < 0.05 mA
HiC283*R1	2 kΩ	24 V	8.0 mA < I <sub>on</sub> < 9.2 mA	0.46 mA < I <sub>off</sub> < 0.62 mA	I <sub>fault</sub> < 0.05 mA
HiC283*R2	250 Ω	24 V	4.2 mA < I <sub>on</sub> < 4.6 mA	1.48 mA < I <sub>off</sub> < 1.62 mA	I <sub>fault</sub> < 0.05 mA
HiC283*R3	4.3 kΩ	24 V	4.9 mA < I <sub>on</sub> < 5.2 mA	1.01 mA < I <sub>off</sub> < 1.06 mA	I <sub>fault</sub> < 0.05 mA
HiC283*R5	250 Ω	24 V	2.54 mA < I <sub>on</sub> < 2.76 mA	0.5 mA < I <sub>off</sub> < 0.55 mA	I <sub>fault</sub> < 0.05 mA

Table 5.1 Input and output values for HiC28\*1, HiC283R2, HiC283\*R3 and HiC283\*R5

Device	1	U <sub>on</sub> (V)	U <sub>off</sub> (V)	I <sub>fault</sub> (mA)
HiC283*R4	10.0 mA	$4.58 \text{ V} < \text{U}_{\text{on}} < 4.85 \text{ V}$	13.3 V < U <sub>off</sub> < 14.35 V	I <sub>fault</sub> < 0.05 mA

Table 5.2 Input and output values for HiC283\*R4

Figure 5.1 Proof test set-up for HiC2831R1

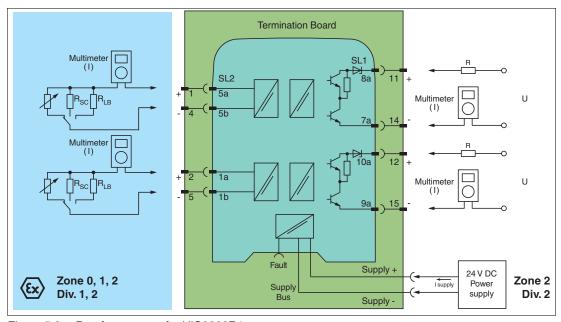


Figure 5.2 Proof test set-up for HiC2832R1

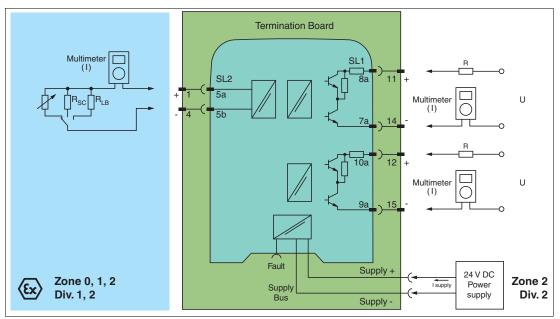


Figure 5.3 Proof test set-up for HiC2831, HiC2831R2, HiC2831R3, and HiC2831R5

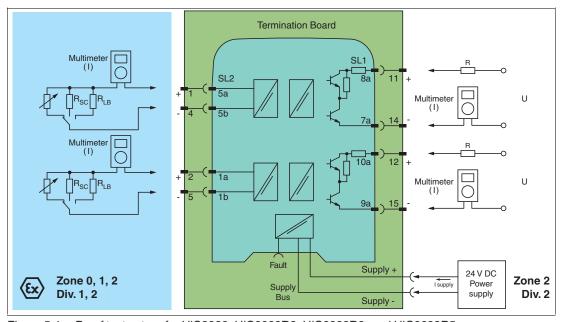


Figure 5.4 Proof test set-up for HiC2832, HiC2832R2, HiC2832R3, and HiC2832R5

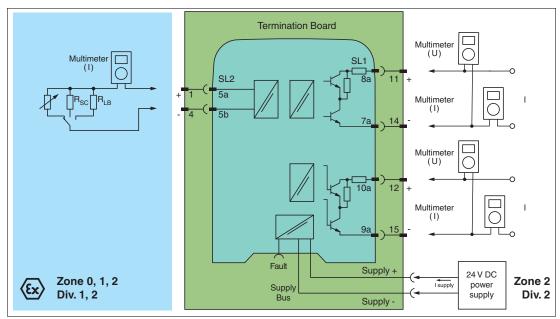


Figure 5.5 Proof test set-up for HiC2831R4

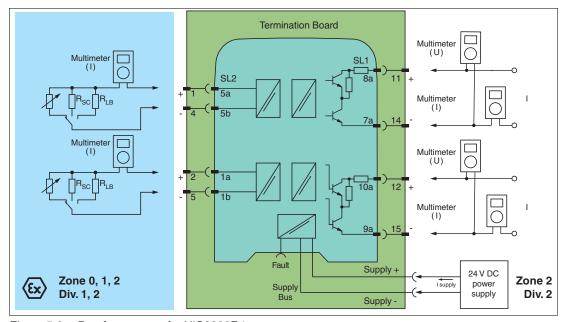


Figure 5.6 Proof test set-up for HiC2832R4



## Tip

The easiest way to test HiC devices is by using a stand-alone HiCTB\*\*-SCT-\*\*\*-\*\* termination board. In this test, it is not necessary to disconnect the wiring of the existing application. Faults in a subsequent wiring can be avoided.

## 6

# **Maintenance and Repair**



## Danger!

Danger to life from missing safety function

Changes to the device or a defect of the device can lead to device malfunction. The function of the device and the safety function is no longer guaranteed.

Do not repair, modify, or manipulate the device.



## Maintaining, Repairing or Replacing the Device

In case of maintenance, repair or replacement of the device, proceed as follows:

- 1. Implement appropriate maintenance procedures for regular maintenance of the safety loop.
- 2. While the device is maintained, repaired or replaced, the safety function does not work. Take appropriate measures to protect personnel and equipment while the safety function is not available.
  - Secure the application against accidental restart.
- 3. Do not repair a defective device. A defective device must only be repaired by the manufacturer.
- 4. If there is a defect, always replace the device with an original device.



## **Reporting Device Failure**

If you use the device in a safety loop according to IEC/EN 61508, it is required to inform the device manufacturer about possible systematic failures.

Report all failures in the safety function that are due to functional limitations or a loss of device function – especially in the case of possible dangerous failures.

In these cases, contact your local sales partner or the Pepperl+Fuchs technical sales support (service line).

It is not necessary to report failures in the safety function that are due to external influences or damage.

## 7 List of Abbreviations

ESD Emergency Shutdown
FIT Failure In Time in 10<sup>-9</sup> 1/h

FMEDA Failure Mode, Effects, and Diagnostics Analysis

 $\lambda_s$  Probability of safe failure

 $\lambda_{dd}$  Probability of dangerous detected failure  $\lambda_{du}$  Probability of dangerous undetected failure

 $\lambda_{\text{no effect}}$  Probability of failures of components in the safety loop that have

no effect on the safety function.

 $\begin{array}{ll} \lambda_{not \, part} & \text{Probability of failure of components that are not in the safety loop} \\ \lambda_{total \, (safety \, function)} & \text{Probability of failure of components that are in the safety loop} \end{array}$ 

HFT Hardware Fault Tolerance

MTBF Mean Time Between Failures

MTTR Mean Time To Restoration

PCS Process Control System

PFD<sub>avg</sub> Average Probability of dangerous Failure on Demand
PFH Average frequency of dangerous failure per hour

PLC Programmable Logic Controller

PTC Proof Test Coverage
SC Systematic Capability
SFF Safe Failure Fraction

SIF Safety Instrumented Function

SIL Safety Integrity Level

SIS Safety Instrumented System

T<sub>1</sub> Proof Test Interval

FLT Fault

LED Lead Breakage
LFD Line Fault Detection

SC Short Circuit

T<sub>service</sub> Time from start of operation to putting the device out of service

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# **Explosion Protection**

- Intrinsic Safety Barriers
- Signal Conditioners
- FieldConnex® Fieldbus
- Remote I/O Systems
- Electrical Ex Equipment
- Purge and Pressurization
- Industrial HMI
- Mobile Computing and Communications
- HART Interface Solutions
- Surge Protection
- Wireless Solutions
- Level Measurement

## **Industrial Sensors**

- Proximity Sensors
- Photoelectric Sensors
- Industrial Vision
- Ultrasonic Sensors
- Rotary Encoders
- Positioning Systems
- Inclination and Acceleration Sensors
- Fieldbus Modules
- AS-Interface
- Identification Systems
- Displays and Signal Processing
- Connectivity

PepperI+Fuchs Quality

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